

Notice of References Cited	Application/Control No. 10/564,312	Applicant(s)/Patent Under Reexamination KUTTNER, FRANZ	
	Examiner Khai M. Nguyen	Art Unit 2819	Page 1 of 1

U.S. PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,650,266	11-2003	Tester, David	341/144
*	B	US-6,768,439	07-2004	Sun, Wein-Town	341/144
*	C	US-6,559,785	05-2003	Kuttner, Franz	341/155
*	D	US-6,163,283	12-2000	Schofield, William George John	341/50
*	E	US-5,844,515	12-1998	Park, Yong In	341/144
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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